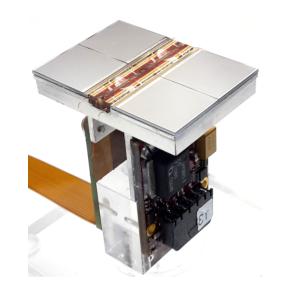


The gaseous QUAD pixel detector



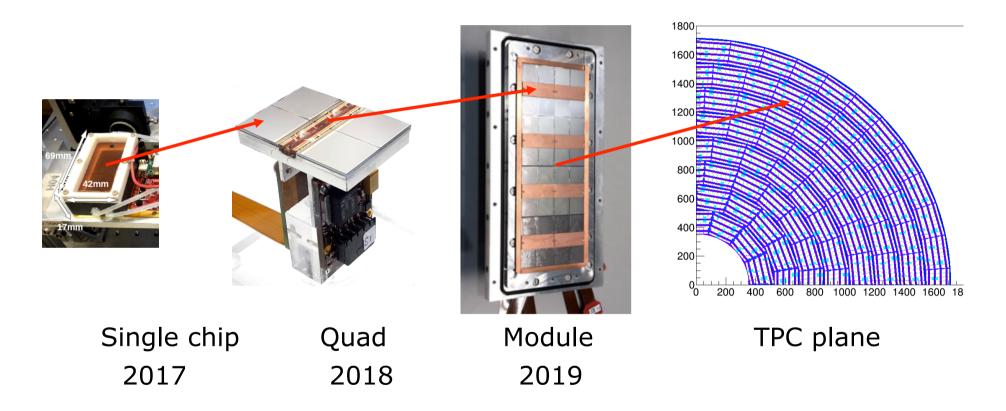
Yevgen Bilevych, Klaus Desch, Jean
-Paul Fransen, Harry van der Graaf,
Markus Gruber, Fred Hartjes, Bas van
der Heijden, Kevin Heijhof, Charles
Ietswaard, Dimitri John, Jochen
Kaminski, Peter Kluit, Naomi van der
Kolk, Auke Korporaal, Cornelis
Ligtenberg, Oscar van Petten, Gerhard
Raven, Joop Rövekamp, Lucian
Scharenberg, Tobias Schiffer,
Sebastian Schmidt and Jan
Timmermans







Pixel TPC



LEPCOL: van quad naar 8 quads

- Single chip geanalyseerd, begrepen en NIM gepubliceerd
- Quad testbeam data zijn geanalyseerd, gepresenteerd in Vienna VCI (Peter) en La Rochelle MPGD (Jochen)
- Kees werkt aan de publicatie NIM
- 8 quad status
 - Laser test opstelling werkt zonder multiplexer
 - ET werk (< september)
 - stabilisatie van voeding (Bas);
 - multiplexer (Sander/Bas) voor 8 quad uitlezing.
- Wie gebruikt er quads:
 - Lab Master UvA/VU (LCB post doc)
 - Lab Master Nijmegen (Frank Filthaut)
 - Bonn CAST en follow-up IAXO experiment;
 - mogelijkheden bij een van de vele TPC experimenten.

LEPCOL: van quad naar 8 quads

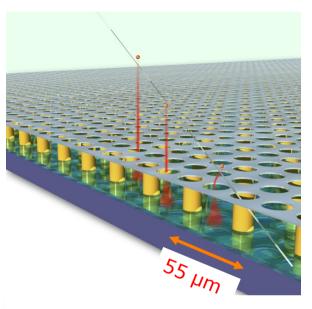
- plannen komende jaar:
 - publicatie quad
 - september test beam data in Bonn met 8 quads
 - eind 2019 LCTPC vergadering
 - begin 2020 test beam DESY
 - presentatie resultaten bij conferenties
- Dit doen we met onze crew: Kees, Fred, Jan, Naomi, Gerhard, Peter (& Bonn collega's)
- Toestemming voor reizen om de test beam voor te bereiden en uit te voeren en resultaten te presenteren.

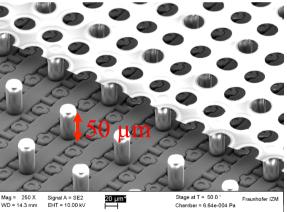
GridPix technology

- Pixel chip with integrated Grid (Micromegas-like)
- InGrid post-processed @ IZM
- Grid set at negative voltage (300 600 V) to provide gas amplification
- Very small pixel size (55 µm)
- detecting individual electrons
- Aluminium grid (1 µm thick)
- 35 µm wide holes, 55 µm pitch
- Supported by SU8 pillars 50 µm high
- Grid surrounded by SU8 dyke (150 µm wide solid strip) for mechanical and HV stability



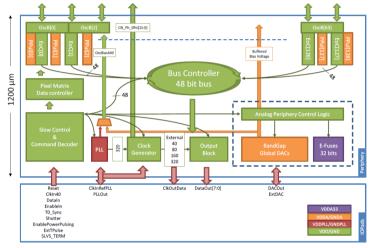


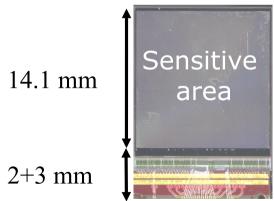




Pixel chip: TimePix3

- 256 x 256 pixels
- 55 x 55 µm pitch
- 14.1 x 14.1 mm sensitive area
- TDC with **610 MHz clock** (1.64 ns)
- Used in the data driven mode
 - Each hit consists of the **pixel address** and **time stamp** of arrival time (ToA)
 - Time over threshold (ToT) is added to register the signal amplitude
 - compensation for time walk
 - **Trigger** (for t₀) added to the data stream as an additional time stamp
- Power consumption
 - ~1 A @ 2 V (2W) depending on hit rate
 - good cooling is important





Single chip test in test beam Bonn (June 2017)

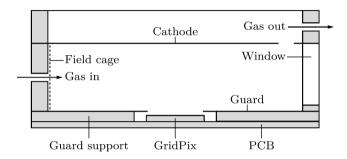
ELSA: 2.5 GeV electrons

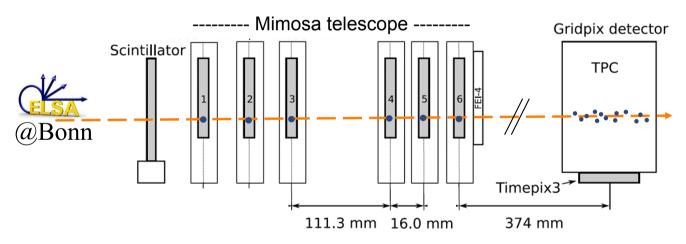
■ Tracks referenced by Mimosa telescope

Gas: $Ar/CF_4/iC_4H_{10}$ 95/3/2 (T2K)

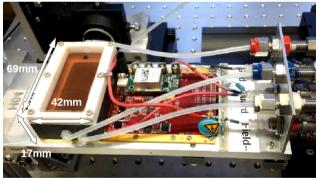
■ Electrons: ~100 e/cm

 $E_d = 280 \text{ V/cm}, V_{grid} = -350 \text{ V}$



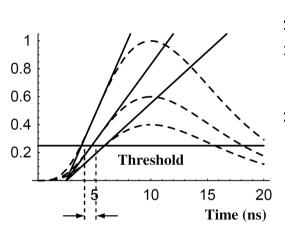


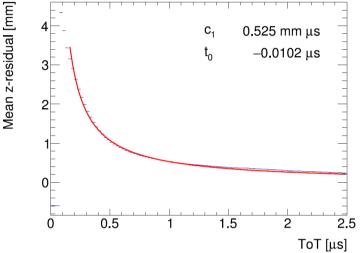


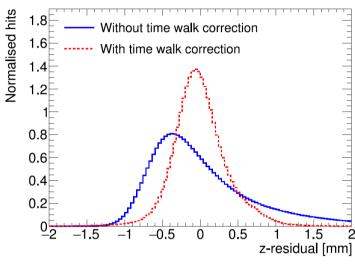


Published paper on 2017 testbeam: https://doi.org/10.1016/j.nima.2018.08.012

TimePix3 time walk correction







Time walk error: time of arrival depends on signal amplitude

Correction using Time over Threshold (ToT) as a measure of signal strength

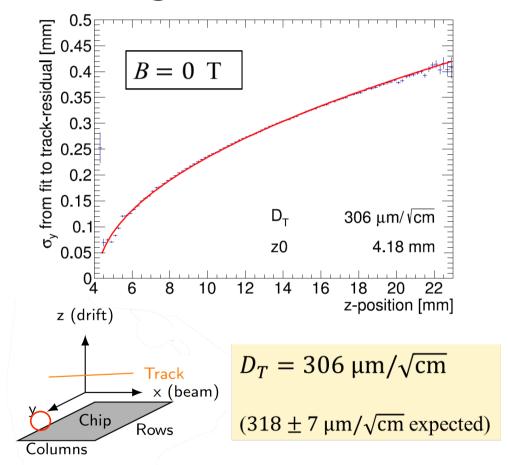
Residual distribution

improved

$$\delta z_{\mathsf{timewalk}} = rac{c_1}{t_{\mathsf{ToT}} + t_0} + z_0$$

(Blum, Particle detection 2008)

Single hit resolution in transverse direction



Single hit resolution in pixel plane:

$$\sigma_y^2 = \sigma_{y0}^2 + D_T^2(z - z_0)$$

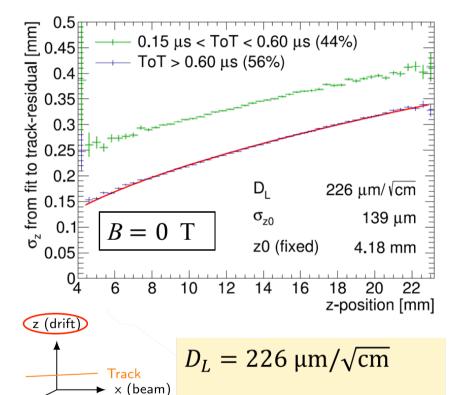
Depends on:

- \Box σ_{v0} = pixel size $/\sqrt{12}$
- \square Diffusion D_T from fit

Note that:

- □ A hit resolution of ~250 μm is ~25 μm for a 100-hit track (~ 1 cm track length)
- \square At B = 4 T, $D_T = 25 \, \mu\text{m}/\sqrt{\text{cm}}$

Single hit resolution in longitudinal direction



Single hit resolution in drift direction

$$\sigma_z^2 = \sigma_{z0}^2 + D_L^2(z - z_0)$$

Depends on

- σ_{z0} from fit
- Diffusion D_L from fit

The additional ToT cut (>0.60 µs) was applied to avoid large time walk errors

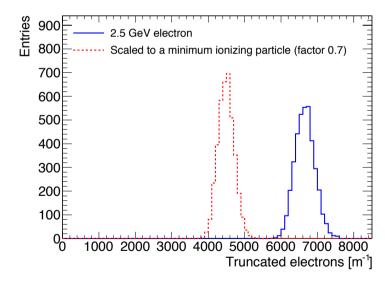
Rows

Columns

 $(201 \pm 5 \,\mu\text{m}/\sqrt{\text{cm}} \,\text{expected})$

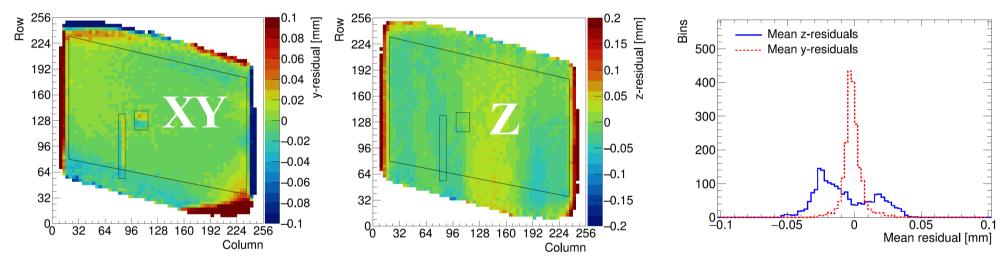
Pixel dE/dx performance

- dE/dx resolution with truncated mean
 - From the single chip tracks; 1 m long tracks are made;
 - nr of electrons counted in slices of 20 pixel and reject 10% highest slices
 - Distances along track are scaled by 1/0.7 to get an estimation for the dE/dx of a MIP
 - Resolution is 4.1% for a 2.5 GeV electron and 4.9% for a MIP
- Separation $S = (N_e N_{MIP})/\sigma_e$
- 8σ MIP-e separation for a 1 meter track
- A pixel readout can in principle within the resolution (diffusion) separate primary from secondary clusters. dE/dx can be measured by cluster counting and performance separation enhanced.



Deformations in pixel plane (XY) and drift direction (Z)

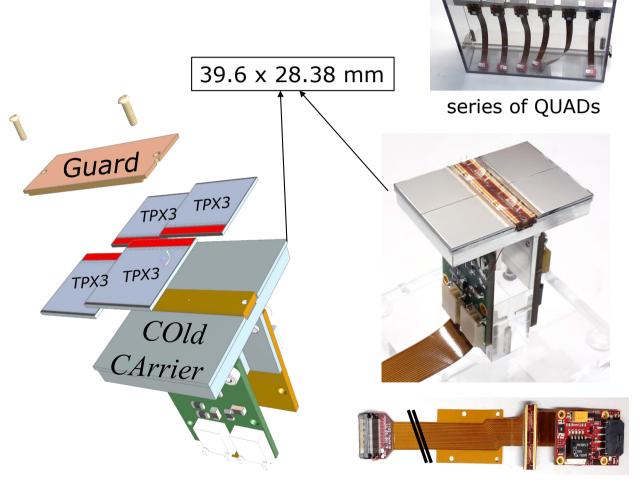
The RMS of the mean residuals is 7 μm in the pixel plane and 21 μm (0.3 ns) in the drift direction in the selected region



- How can we make an even better detector?
 - Improve the quality (homogenity) of the InGrid; redesign the dike and edges
 - Go to a large areas keeping the field distortions (at edges) minimal -> QUAD

QUAD design and realization

- Four-TimePix3 chips
- All services (signal IO, LV power) are located under the detection surface
- The area for connections was squeezed to the minimum
- Very high precision 10 µm mounting of the chips and guard
- QUAD has an sensitive area of 68.9%
- DAQ by SPIDR



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QUAD test beam in Bonn (October 2018)

QUAD

Field cage

ef)

■ ELSA: 2.5 GeV electrons

@Bonn

- Tracks referenced by Mimosa telescope
- QUAD sandwiched between Mimosa planes
 - Largely improved track definition
- Gas: $Ar/CF_4/iC_4H_{10}$ 95/3/2 (T2K)

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 $E_d = 280 \text{ V/cm}, V_{grid} = -300 \text{ V}$

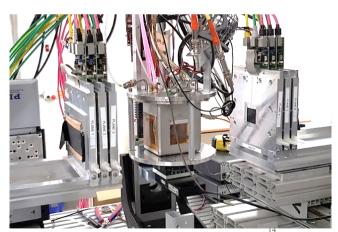
■ Typical beam height above the chip: ~1 cm

MIMOSA telescope

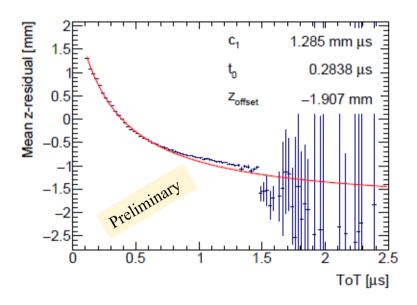
140 mm

140 mm

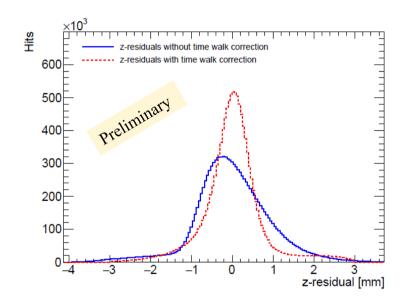
Preliminary results will be presented here



QUAD time walk results

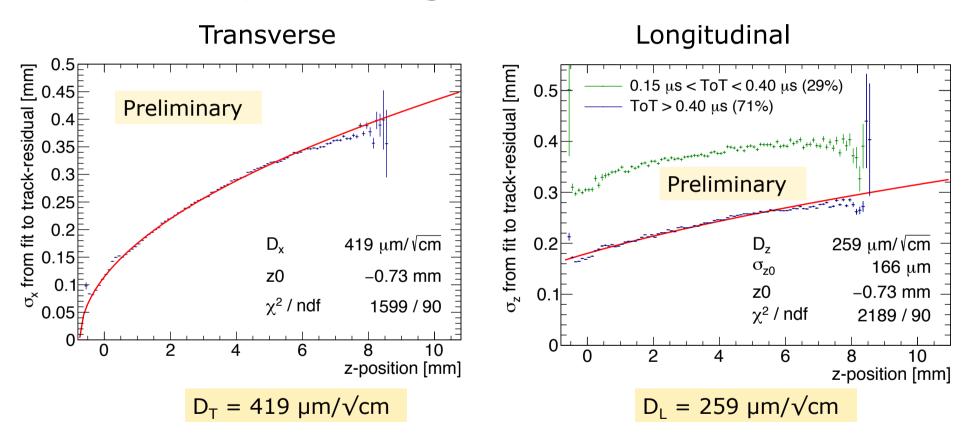


$$\delta z_{\mathsf{timewalk}} = \frac{c_1}{t_{\mathsf{ToT}} + t_0} + z_0$$



- Time walk correction works well
- Applied for all analysis results

QUAD single hit resolution

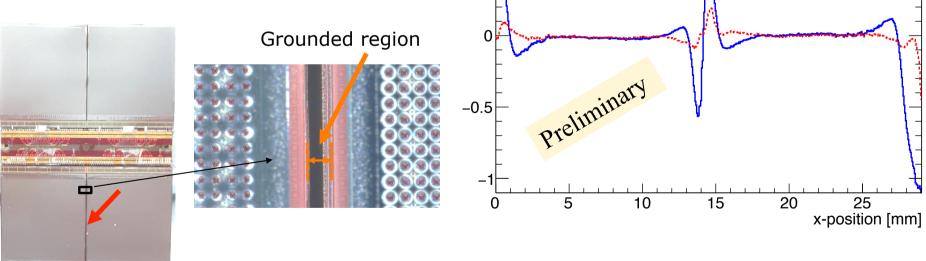


QUAD edge deformations

Before correction

After correction

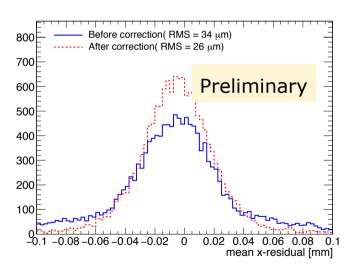
- Small deformations due to
 - Dead zone between chips
 - Grounded region between chips
- Are corrected by:
 - fitted correction function
 - adding proper guard wire electrode



x-residual [mm]

QUAD deformations in transverse plane (XY)

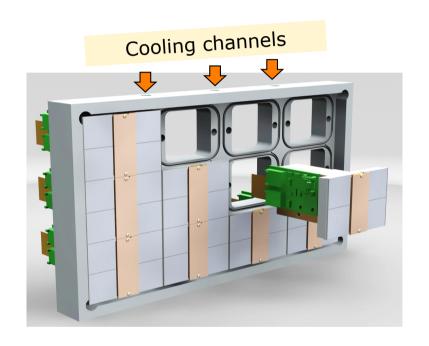
- After applying fitted edge corrections
- RMS of the mean residuals are 26 µm over the whole QUAD



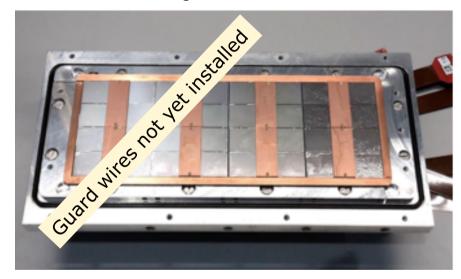
0.0 0.08 0.00 wean x-residual [mm] 15 Preliminary 0.02 -0.02-0.04-0.06-10 -0.08 10 15 20 25 x [mm]

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Next: QUAD as a building block



8-QUAD module



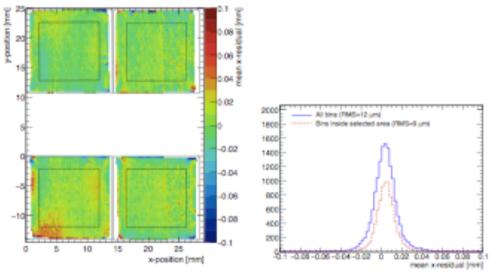
Conclusions

- Since 2017 three TimePix3 wafers were successfully equipped with an InGrid
- A single chip GridPix detector from this production was reliably operated in a test beam in 2017
 - Single electron detection => the resolution is primarily limited by diffusion
 - Systematic uncertainties are low: < 10 µm in the pixel plane
 - dE/dx resolution for a 1 m track is 4.1%
- Preliminary results from a recent 2018 QUAD test beam were presented
- Data quality and resolutions are similar to the single chip test beam results
- Small edge deformations at the boundary between two chips are observed
 - We will add guard wires to the module
- A production of 14 QUADs is finished
 - QUADs are installed in an 8-QUAD module



Understanding the quad

Deformation in pixel plane



Introducing a y-coordinate dependence improves corners, but there is no difference for the central region

Deformation in drift direction

